Form No. QRF/2018-14/Rev-5

Report No.ERTL(E)/TES/F061/0023/03-24/NABL (AMENDMENT-1)



TEST REPORT

ON

AI BASED FACE RECOGNITION ATTENDANCE SYSTEM FORTUNA

OF

FORTUNA IMPEX PVT. LTD. P-73, KASBA INDUSTRIAL ESTATE PHASE-II, ANANDAPUR KOLKATA 700107 WEST BENGAL



Government of India

Ministry of Electronics and Information Technology Standardisation Testing and Quality Certification Directorate ELECTRONICS REGIONAL TEST LABORATORY (EAST) Block DN63, Sector-V, Salt Lake, Kolkata-700 091 INDIA



Government of India Ministry of Electronics & Information Technology STQC Directorate ELECTRONICS REGIONAL TEST LABORATORY (EAST) Kolkata

Form No.:QRF/2023-29/Rev-7

TEST	REPORT ON : A	AI BASED F	ACE RECO	OGNITION ATTI	ENDANCE SYSTEM	PAGE 01 OF 4			
1.0	SCOPE								
1.1	Service Request	No.	: TE	/0023/03-24					
1.2	Test Report No.			: ERTL(E)/TES/F061/0023/03-24/NABL (AMENDMENT-1) Date : 31-05-2024					
	ULR No.		: TC	5637240000006	2F				
1.3	Requested by		: F	ORTUNA IMPEX	PVT. LTD.				
	(Name & addres of the organisat		к	-73, KASBA INDI OLKATA-700107 /EST BENGAL	JSTRIAL ESTATE.PHASE-II, A	NANDAPUR			
1.4	Description Identification of the item to be tested	ltem Make Model SI.No. Qty	: FC : VF	BASED FACE F ORTUNA 2000 2822301000007	RECOGNITION ATTENDANC	CE SYSTEM			
1.4.1	Applicable Spec.	of the item(s)	tested :	I/P VOLTAGE:	12V DC				
1.4.2	Characterisation	and	С	haracterisation	: Not applicable				
	condition of item		C	ondition	: Satisfactory				
1.5	Date of receipt o	f item			: 22-03-2024				
1.6	Date of start of te	esting			: 01-04-2024				
1.6.1	Date of completion	on of testing			: 30-04-2024				
1.7	Location where t	esting perforn	ned		: IN HOUSE				
B Ar	mbient condition d	uring measure	ement		: 25+/-2 °C 45-70%RH				
1.9	9 Discipline : E			RICAL DISCIPLIN	IE				
1.9.1	Spec. used for te	esting	:		IP65 TEST AS PER IEC 60529	:2013			
1.9.2	Details of non sta	andard metho	d followed (i	f any):					

This report is digitally signed by authorised signatory

भारत सरकार इलेक्ट्रॉनिकी और सूचना प्रौद्योगिकी मंत्रालय एस टी क्यू सी निदेशालय इलेक्ट्रॉनिकी क्षेत्रीय परीक्षण प्रयोगशाला (पूर्व) कोलकाता



Kolkata

Form No. QRF/2023-29/Rev-7

TEST REPORT NO: ERTL(E)/TES/F061/0023/03-24/NABL(AMENDMENT-1)		
REPORT ON: AI BASED FACE RECOGNITION ATTENDANCE SYSTEM. Make: FORTUNA, Model: VF2000, SL. NO.: 6728223010000070	PAGE 2	OF 4

TEST RESULT:

SI.	Test of Environment	Clause No.	Quantity		Specifications	Test Result	Notes
No			Tested	Failed	Limit	Test Result	notes
1.	IP 6X Test: Dust tight test: Dust: Talcum Powder. Vacuum: 200 mm of water column. Duration: 8 Hours.	13.4 &13.6 of IEC 60529: 2013	1	0	The protection is satisfactory if no deposit of dust is observed inside the Test item at the end of the test.	Complied. No dust entered inside the Test item.	
2.	Pre IP X5 Performance Test: Input voltage: 12VDC through adaptor supplied by customer	Customer's Spec.	1	0	System should start with proper display	Complied	
3.	IP X5 Test: Protected against water jets: Nozzle dia : 6.3 mm. Water flow rate : 12.5 liter /minute Duration : 3 minutes. Distance between nozzle to enclosure surface : 3 Meter.	14.2.5 & 14.3 of IEC 60529: 2013	1	0	Amount of water entered, if any, inside the Test item shall not interfere with the correct operation of the apparatus or impair safety.	Complied. No water entered inside the system.	
4.	Final Performance Test : Input voltage: 12VDC through adaptor supplied by customer	Customer's Spec.	1	0	System should start with proper display	Complied	



Government of India Ministry of Electronics & Information Technology STQC Directorate ELECTRONICS REGIONAL TEST LABORATORY (EAST) Kolkata

Form No.:QRF/2023-29/Rev-7

TEST REPORT ON : A	AI BASED FACE REC	OGNITION A	TTENDANCE SYS	TEM	PAGE 03 OF 4
TEST REPORT NO. :	ERTL(E)/TES/F061/ Date : 31-05-2024	/0023/03-24/NA	BL (AMENDMENT-1)	
ULR No. :	TC5637240000006	32F			
3.0 Equipment used EQPT_NO NAME		MAKE	MODEL	CAL.VALID	UPTO
Please see the ANNE	XURE'EQUIPMENT U	SED' for detail	ls of equipment used	for testing.	
The competent authority photographs of test sam available and accordingl	s conducted have been mer has taken a decision to incl ple where product standard y the report has been amen hs of the test sample (see a ort).	lude the is ded	ad 'TEST RESULT'		
				Scan to verify of the repo	the originality
	TC56	1	ro verify NABL certificate		
			Digitally si PABITRA CHATTOP		

Authorised Signatory

DHYAY

Date: 2024.05.31

15:33:13 +05'30'



Government of India Ministry of Electronics & Information Technology STQC Directorate ELECTRONICS REGIONAL TEST LABORATORY (EAST) Kolkata

Form No.:QRF/2023-29/Rev-7

TEST REPORT ON : AI BASED FACE RECOGNITION ATTENDANCE SYSTEM

PAGE 4 OF 4

TEST REPORT NO.

: ERTL(E)/TES/F061/0023/03-24/NABL (AMENDMENT-1) Date : 31-05-2024

ULR No. :

TC56372400000062F

NOTES

1. This certificate/ report refer only to the particular item submitted for calibration/test.

2. The certificate/report, if reproduced for any purpose, commercial or otherwise, should be reproduced in full. The reproduction of a part, or an abstract thereof, has to be got specially approved from Director, Electronics Regional Test Laboratory (East).

3. The results reported in the certificate /reports are valid at the time of and under the stated conditions on measurement.

4. Calibration need to be done periodically to maintain the accuracy of the measurement. (in case of calibration report only)

5. Decision Rule (Details available in ERTL (E) QMS document will be provided as on request): Measured value of a test parameter with uncertainty at certain confidence level shall be within Specified Limit/tolerance of relevant standard then the conformity to the standard / specification is achieved and reported.

6. Decision rule will not be stated in the Report for below mentioned situations

- In absence of acceptance criteria (results shall be reported.)
- Specify otherwise (if any)

7. This report is reviewed and approved by Head Test.



Released By

Form No.:QRF/2023-29/Rev-7

ANNEXURE - [EQUIPMENT USED] Details of equipment used for testing

TEST REPORT NO. :	ERTL(E)/TES/F061/0023/03-24/NABL (AMENDMENT-1)	Date : 31-05-2024
ULR No. :	TC56372400000062F	

<u>EQPT NO</u>	NAME	MAKE	MODEL	CAL.VALID UPTO
1120	DUST CHAMBER	KASCO INDUSTRIES	PUNE	05-03-2025
1018	MULTIMETER	AGILENT TECHNOLO	34401A	21-03-2025
1771	WATER FLOW METER	ATCO	0 to 16.0 L/m	06-07-2024
1091	WATER JET(PRES GAUGE)	A.N.INSTRUMENTS	0-2.5 KG	19-12-2024

Note: All testing were conducted within the validity period of respective equipment shown above.

This report is digitally signed by authorised signatory

भारत सरकार इलेक्ट्रॅनिकी और सूचना प्रौद्योगिकी मंत्रालय एस टी क्यू सी निदेशालय इलेक्ट्रॅनिकी क्षेत्रीय परीक्षण प्रयोगशाला (पूर्व) कोलकाता



Annexure - I

REPORT NO: ERTL(E)/TES/ F061/0023/03-24/NABL(AMENDMENT-1)

PHOTOGRAPH OF AI BASED FACE RECOGNITION ATTENDANCE SYSTEM. Make: FORTUNA, Model: VF2000, SL. NO.: 6728223010000070







This report is digitally signed by authorized signatory